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Shenzhen, Guangdong, China 518057

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TEST REPORT

Application No.: SZEM1704003556BA Applicant: Flashbay Electronics

Address of Applicant: Blgd b & C Xi Feng Cheng IND Zone, No. 2 FuYuan Road He Ping, Village,

FuYong Town, ShenZhen

Manufacturer: Flashbay Electronics

Address of Manufacturer: Blgd b & C Xi Feng Cheng IND Zone, No. 2 FuYuan Road He Ping, Village,

FuYong Town, ShenZhen

Factory: Flashbay Electronics

Blgd b & C Xi Feng Cheng IND Zone, No. 2 FuYuan Road He Ping, Village, Address of Factory:

FuYong Town, ShenZhen

Equipment Under Test (EUT):

EUT Name: power bank Model No.: Tour(TR) EN 55032:2015

Standards:

(only for Conducted Disturbance at Mains Terminals and Radiated Disturbance)

2017-04-27 Date of Receipt:

2017-05-03 to 2017-05-08 Date of Test:

Date of Issue: 2017-05-12

Pass* Test Result:

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EU Declaration of Conformity and compliance with all relevant EU Directives.





Jack Zhang EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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^{*} In the configuration tested, the EUT complied with the standards specified above.



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Revision Record									
Version	Version Chapter Date Modifier								
01		2017-05-12		Original					

Authorized for issue by:		
Tested By	Forychon	2017-05-08
	Foray Chen /Project Engineer	Date
Checked By	Eric Fu	2017-05-12
	Eric Fu /Reviewer	Date



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2 Test Summary

Emission Part									
Item	Standard	Method	Requirement	Result					
Conducted Disturbance at Mains Terminals (150kHz-30MHz)	EN 55032:2015	EN 55032:2015	Class B	Pass					
Radiated Disturbance (30MHz-1GHz)	EN 55032:2015	EN 55032:2015	Class B	Pass					

InternalSource	UpperFrequency
Below 108MHz	1GHz
108MHz to 500MHz	2GHz
500MHz to 1GHz	5GHz
Above 1GHz	5 times the highest frequency or 6 GHz, whichever is less

Remark:

Model No.: Tour(TR)

This test report (Ref. No.: SZEM160400216402) is only valid with the original test report (Ref. No.: SZEM160400216401).

Compared with the original report, this report changed the model No., Since the electrical circuit design, layout, components used and internal wiring for the model in the report SZEM160400216402 were exactly the same as the model in original report SZEM160400216401, only different on model No..

Review this report and the original report, this report updated the below standards.

Original report standard The newest report standard

EN 55022:2010 EN 55032:2015

Considering to the difference, pre-scan were performed on the sample in this report to find the items which can be influential to the result in the original test report for fully retest.

Therefore in this report Radiated Disturbance (30MHz-1GHz)and Conducted Disturbance at Mains Terminals(150kHz-30MHz) were fully retested on Model Tour(TR) and shown the data in this report, other tests please refer to original report SZEM160400216401



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4 General Information

4.1 Details of E.U.T.

Power supply: Input Voltage: DC5V 1A

Output Voltage: DC5V 1A

Rechargeable Battery Capacity: 2500mAh

Cable: USB Cable: 3cm Unshielded

4.2 Description of Support Units

Description	Description Manufacturer		Serial No.		
Adapter	Apple	A1357 W010A051	REF. No.SEA0500		
Load Resistor	SGS	N/A	REF. No.SEA0600		
USB Cable	PHILIPS	SWR2101	REF. No.SEA0700		

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Conduction emission	3.0dB (150kHz to 30MHz)
2	Radiated emission	4.5dB (30MHz-1GHz)
3	Temperature test	1℃
4	Humidity test	3%



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4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

· CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

• FCC – Registration No.: 556682

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None



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5 Equipment List

Conducted Disturbance at Mains Terminals(150kHz-30MHz)								
Equipment Manufacturer Model No Inventory No Cal Date Cal Due Date								
Shielding Room	ChangZhou ZhongYu	GB-88	SEM001-06	2017-05-10	2018-05-10			
LISN	Rohde & Schwarz	ENV216	SEM007-01	2016-10-09	2017-10-09			
LISN	ETS-LINDGREN	3816/2	SEM007-02	2017-04-14	2018-04-14			
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2017-04-14	2018-04-14			

Radiated Disturbance(30MHz-1GHz)								
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2017-05-10	2018-05-10			
EMI Test Receiver	Rohde & Schwarz	ESR	SEM004-03	2017-04-14	2018-04-14			
(9k-3GHz)								
Trilog-Broadband Antenna	Schwarzbeck	VULB9168	SEM003-18	2016-06-29	2019-06-29			
(30M-1GHz)								
Pre-amplifier	Sonoma Instrument Co	310N	SEM005-03	2016-07-06	2017-07-06			

General used equipment								
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2016-10-12	2017-10-12			
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2016-10-12	2017-10-12			
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2016-10-12	2017-10-12			
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2016-05-18	2017-05-18			



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6 Emission Test Results

6.1 Conducted Disturbance at Mains Terminals(150kHz-30MHz)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: 150kHz to 30MHz

Limit:

0.15M-0.5MHz 66dB(μ V)-56dB(μ V) quasi-peak, 56dB(μ V)-46dB(μ V) average

0.5M-5MHz 56dB(μ V) quasi-peak, 46dB(μ V) average 5M-30MHz 60dB(μ V) quasi-peak, 50dB(μ V) average

Detector: Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

6.1.1 E.U.T. Operation

Operating Environment:

Temperature: 25.0 °C Humidity: 55 % RH Atmospheric Pressure: 1015 mbar

a: Charge mode, keep EUT being charged with adapter.

Pretest these mode to find the worst case:

c: Charge and full output mode, keep EUT being charged with adapter and working

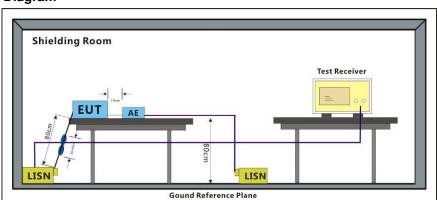
with full load. d: Idle mode.

The worst case

c: Charge and full output mode, keep EUT being charged with adapter and working

for final test: with full load.

6.1.2 Test Setup Diagram



6.1.3 Measurement Data

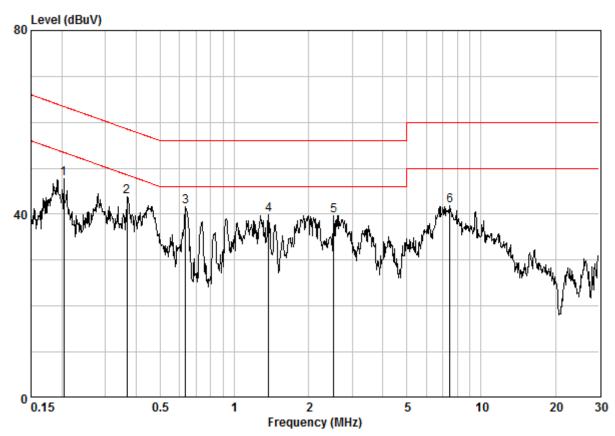
An initial pre-scan was performed with peak detector.Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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Mode:c; Line:Live Line



Site : Shielding Room Condition : CE LINE Job No. : 03556BA Mode : c

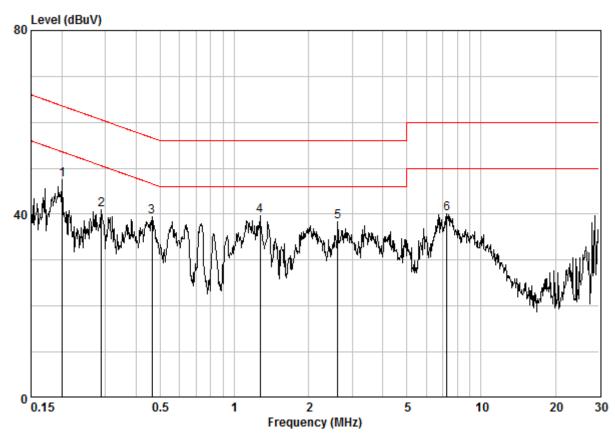
	Freq		LISN Factor					Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.20396	0.02	9.64	38.04	47.70	53.45	-5.75	Peak
2	0.36725	0.02	9.64	34.06	43.72	48.56	-4.84	Peak
3	0.63383	0.02	9.65	31.91	41.59	46.00	-4.41	Peak
4	1.374	0.03	9.66	30.20	39.89	46.00	-6.11	Peak
5	2.527	0.03	9.68	30.07	39.78	46.00	-6.22	Peak
6	7.486	0.09	9.80	31.99	41.88	50.00	-8.12	Peak



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Mode:c; Line:Neutral Line



Site : Shielding Room Condition : CE NEUTRAL Job No. : 03556BA Mode : c

	Freq		LISN Factor					Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.20075	0.02	9.63	37.82	47.47	53.58	-6.11	Peak
2	0.28935	0.02	9.63	31.32	40.97	50.54	-9.58	Peak
3	0.46367	0.02	9.63	29.73	39.38	46.63	-7.24	Peak
4	1.269	0.03	9.64	29.93	39.61	46.00	-6.39	Peak
5	2.622	0.03	9.66	28.69	38.38	46.00	-7.62	Peak
6	7.252	0.08	9.78	30.24	40.11	50.00	-9.89	Peak



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6.2 Radiated Disturbance(30MHz-1GHz)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: 30MHz to 1GHz

Measurement Distance: 10m

Limit:

30 MHz - 230 MHz $30 \text{ dB}(\mu\text{V/m})$ quasi-peak 230 MHz - 1 GHz $37 \text{ dB}(\mu\text{V/m})$ quasi-peak

Detector: Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz



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6.2.1 E.U.T. Operation

Operating Environment:

Temperature: 22.0 °C Humidity: 53 % RH Atmospheric Pressure: 1015 mbar

a: Charge mode, keep EUT being charged with adapter.

Pretest these

b: Full output mode, keep EUT working with full load.

mode to find the worst case:

c: Charge and full output mode, keep EUT being charged with adapter and working

with full load.

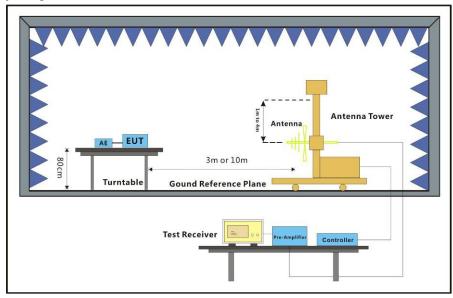
d: Idle mode.

The worst case for final test:

c: Charge and full output mode, keep EUT being charged with adapter and working

al test: with full load.

6.2.2 Test Setup Diagram



6.2.3 Measurement Data

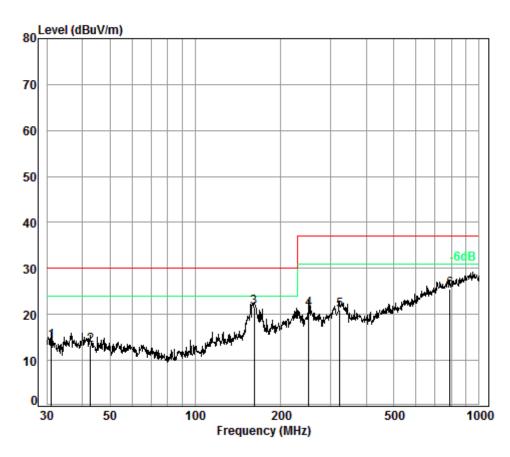
An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.



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Mode:c; Polarization:Horizontal



Condition: 10m HORIZONTAL

Job No. : 03556BA

Test Mode: c

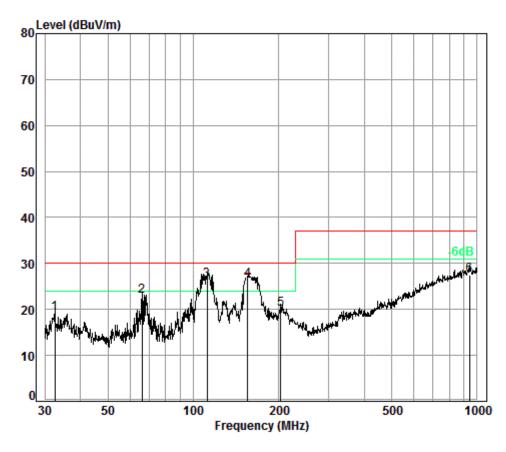
	Freq			Preamp Factor				
_	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	31.18	6.99	12.51	32.97	27.59	14.12	30.00	-15.88
2	42.75	6.80	13.08	32.99	26.49	13.38	30.00	-16.62
3 pp	161.47	7.45	13.24	32.73	33.68	21.64	30.00	-8.36
4	251.18	7.74	11.27	32.64	34.82	21.19	37.00	-15.81
5	323.32	8.18	13.32	32.60	32.09	20.99	37.00	-16.01
6	787.85	9.75	21.15	32.60	27.25	25.55	37.00	-11.45



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Mode:c; Polarization:Vertical



Condition: 10m VERTICAL

Job No. : 03556BA

Test Mode: c

	Freq			Preamp Factor				Over Limit
-	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	32.63	6.98	12.56	32.97	32.69	19.26	30.00	-10.74
2	66.03	6.90	10.80	32.92	38.08	22.86	30.00	-7.14
3	111.80	7.48	10.58	32.78	41.19	26.47	30.00	-3.53
4 pp	155.70	7.46	13.40	32.74	38.50	26.62	30.00	-3.38
5	203.52	7.37	9.38	32.70	36.11	20.16	30.00	-9.84
6	938.83	10.14	22.65	32.50	27.26	27.55	37.00	-9.45



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7 Photographs

7.1 Conducted Disturbance at Mains Terminals(150kHz-30MHz) Test Setup



7.2 Radiated Disturbance(30MHz-1GHz) Test Setup



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7.3 **EUT Constructional Details**







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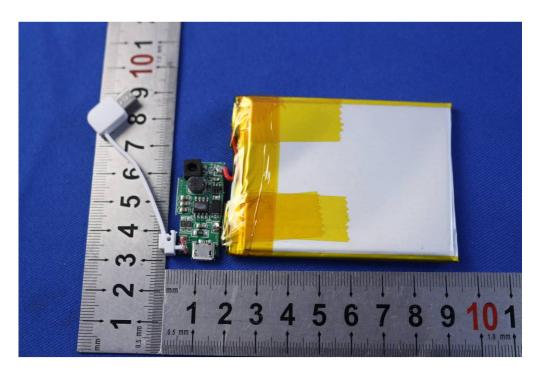




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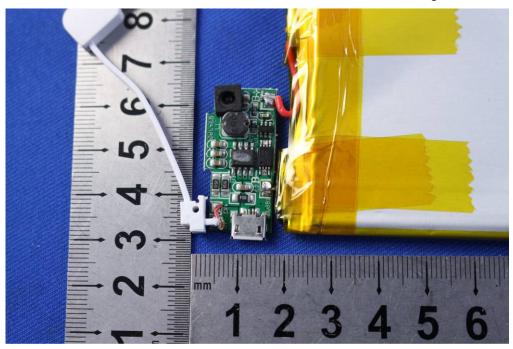


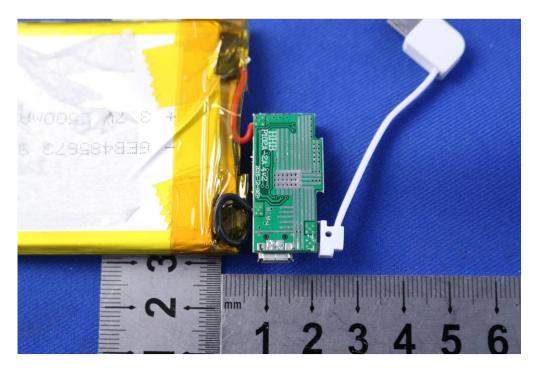




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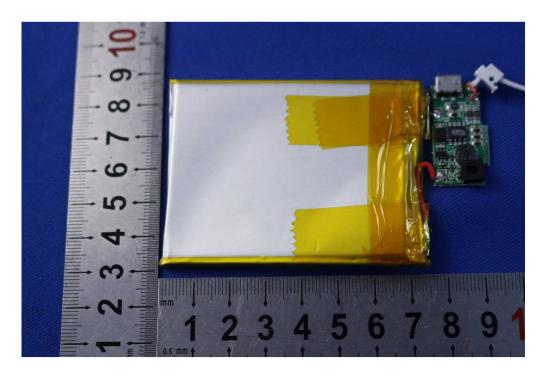




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